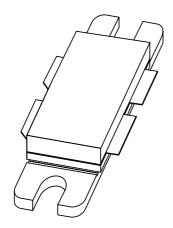
## **DISCRETE SEMICONDUCTORS**

## DATA SHEET



# **BLF647**UHF power LDMOS transistor

Product specification Supersedes data of 2001 Aug 02 2001 Nov 27





## **UHF power LDMOS transistor**

**BLF647** 

#### **FEATURES**

- · High power gain
- · Easy power control
- · Excellent ruggedness
- Source on underside eliminates DC isolators, reducing common mode inductance
- Designed for broadband operation (HF to 800 MHz)
- Internal input damping for excellent stability over the whole frequency range.

#### **APPLICATIONS**

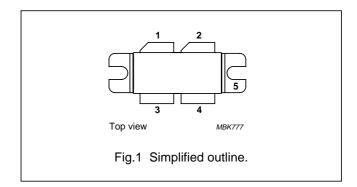
 Communication transmitter applications in the HF to 800 MHz frequency range.

#### **DESCRIPTION**

Silicon N-channel enhancement mode lateral D-MOS push-pull transistor in a SOT540A package with ceramic cap. The common source is connected to the mounting flange.

#### **PINNING - SOT540A**

PIN	DESCRIPTION
1	drain 1
2	drain 2
3	gate 1
4	gate 2
5	source, connected to flange



#### **QUICK REFERENCE DATA**

RF performance at T<sub>h</sub> = 25 °C in a common source test circuit.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	d <sub>im</sub> (dBc)
CW, class-AB	600	28	120	>14.5	>55	_
2-tone, class-AB	f <sub>1</sub> = 600; f <sub>2</sub> = 600.1	28	120 (PEP)	>14.5	>40	≤–26

#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage		_	65	V
V <sub>GS</sub>	gate-source voltage		_	±15	V
I <sub>D</sub>	drain current (DC)		_	18	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> ≤ 25 °C	_	290	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>i</sub>	junction temperature		_	200	°C

#### **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

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#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	$T_{mb} = 25  ^{\circ}C;  P_{tot} = 290  W$	0.6	K/W
R <sub>th mb-h</sub>	thermal resistance from mounting base to heatsink		0.2	K/W

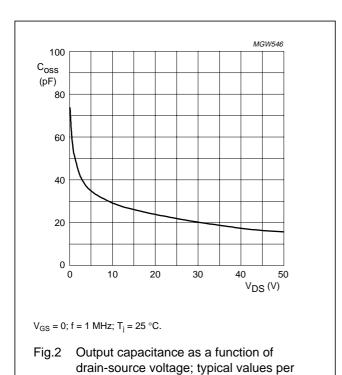
#### **CHARACTERISTICS**

 $T_j = 25$  °C per section unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	V <sub>GS</sub> = 0; I <sub>D</sub> = 1.4 mA	65	_	_	V
$V_{GSth}$	gate-source threshold voltage	V <sub>DS</sub> = 20 V; I <sub>D</sub> = 140 mA	4	_	5.5	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V	_	_	1.2	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GSth} + 9 \text{ V}; V_{DS} = 10 \text{ V}$	18	_	_	Α
I <sub>GSS</sub>	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0$	_	_	25	nA
g <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 20 V; I <sub>D</sub> = 4 A	_	4	_	S
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = V_{GSth} + 9 \text{ V}; I_D = 4 \text{ A}$	_	160	_	mΩ
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz; note 1	_	80	_	pF
C <sub>oss</sub>	output capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	_	43	_	pF
C <sub>rss</sub>	feedback capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	_	6	_	pF

#### Note

1. Capacitance values of the die only.



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section.

### **UHF** power LDMOS transistor

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#### **APPLICATION INFORMATION**

RF performance in a common source class-AB circuit. T<sub>h</sub> = 25 °C; R<sub>th mb-h</sub> = 0.2 K/W, unless otherwise specified.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	d <sub>im</sub> (dBc)
CW, class-AB	600	28	120	>14.5	>55	-
2-tone, class-AB	$f_1 = 600$ ; $f_2 = 600.1$	28	120 (PEP)	>14.5	>40	≤–26
CW, class-AB	800	32	150	typ. 12.5	typ. 60	_
2-tone, class-AB	$f_1 = 800$ ; $f_2 = 800.1$	32	150 (PEP)	typ. 13	typ. 45	typ30

#### Ruggedness in class-AB operation

The BLF647 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS} = 28 \text{ V}$ ; f = 100 MHz at rated load power.

The BLF647 is capable of withstanding abrupt source or load mismatch errors under the nominal power conditions.

#### Impedances (per section)

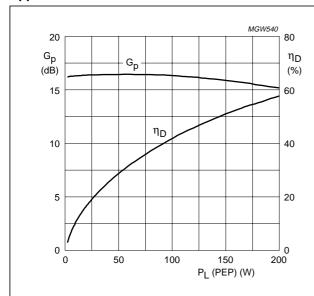
At f = 600 MHz,  $P_L$  = 120 W,  $V_{DS}$  = 28 V and  $I_{DQ}$  = 1 A:  $Z_{in}$  = 1.0 + j2.0  $\Omega$  and  $Z_L$  = 2.7 + j0.7  $\Omega$ .

At f = 800 MHz,  $P_L$  = 150 W,  $V_{DS}$  = 32 V and  $I_{DQ}$  = 1 A:  $Z_{in}$  = 1.0 + j3.8  $\Omega$  and  $Z_L$  = 1.8 + j0.7  $\Omega$ .

## **UHF** power LDMOS transistor

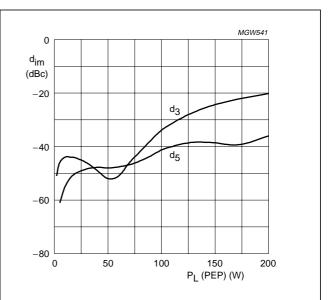
**BLF647** 

#### Application at 600 MHz



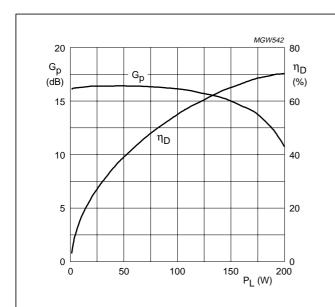
 $T_h$  = 25 °C;  $V_{DS}$  = 28 V;  $I_{DQ}$  = 1 A. 2-tone:  $f_1$  = 600 MHz (–6 dB);  $f_2$  = 600.1 MHz (–6 dB) measured in 600 MHz test circuit.

Fig.3 Power gain and drain efficiency as functions of peak envelope load power; typical values



 $T_h$  = 25 °C;  $V_{DS}$  = 28 V;  $I_{DQ}$  = 1 A. 2-tone:  $f_1$  = 600 MHz (–6 dB);  $f_2$  = 600.1 MHz (–6 dB) measured in 600 MHz test circuit.

Fig.4 Intermodulation distortion as a function of peak envelope output power; typical values.



 $T_h$  = 25 °C;  $V_{DS}$  = 28 V;  $I_{DQ}$  = 1 A; CW, class-AB; f = 600 MHz; measured in 600 MHz test circuit.

Fig.5 Power gain and drain efficiency as functions of load power; typical values.

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Philips Semiconductors

Product specification

 $^{+}V_{D}$ 

Dimensions in mm.

Fig.6 Class-AB common source 600 MHz test circuit.

## UHF power LDMOS transistor

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#### List of components class-AB 600 MHz test circuit (see Figs 6 and 7)

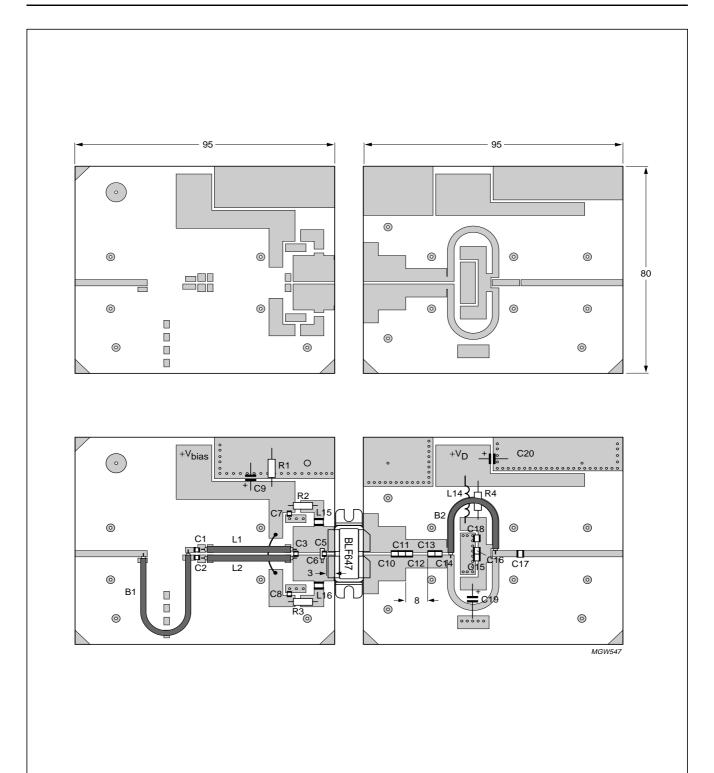
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE No.
C1, C2	multilayer ceramic chip capacitor; note 1	30 pF		
C3	multilayer ceramic chip capacitor; note 1	8.2 pF		
C5	multilayer ceramic chip capacitor; note 1	16 pF		
C6	Tekelec trimmer	0.6 to 7.5 pF		
C7, C8	multilayer ceramic chip capacitor; note 1	100 pF		
C9	electrolytic capacitor	10 μF		
C10	multilayer ceramic chip capacitor; note 2	2 pF		
C11, C12	multilayer ceramic chip capacitor; note 2	10 pF		
C13	multilayer ceramic chip capacitor; note 2	8.2 pF		
C14	multilayer ceramic chip capacitor; note 2	1.5 pF		
C15, C16, C17	multilayer ceramic chip capacitor; note 2	100 pF		
C18	SMD capacitor	1 μF		2222 595 16754
C19	electrolytic capacitor	470 μF		
C20	electrolytic capacitor	100 μF		
L1, L2	semi rigid coax UT70-25	$Z = 25 \Omega \pm 1.5 \Omega$	30.6 mm	
L3, L4	stripline; note 3		15 × 10 mm	
L5, L6	stripline; note 3		5.5 × 15 mm	
L7, L8	stripline; note 3		10 × 10 mm	
L9, L10	stripline; note 3		15 × 5 mm	
L11, L12	stripline; note 3		48.5 × 2.4 mm	
L13	stripline; note 3		10 × 2.4 mm	
L14	ferrite			
L15, L16	Coilcraft SMD coil 1008CS-102XKBC	1 μΗ		
B1	semi rigid coax (lambda/2)	$Z = 50 \Omega \pm 1.5 \Omega$	lambda/2	
B2	semi rigid coax balun UT70-25	$Z = 25 \Omega \pm 1.5 \Omega$	48.5 mm	
R1	resistor	1 kΩ		
R2, R3	resistor	100 Ω		
R4	resistor	3,3 Ω		

#### **Notes**

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. American Technical Ceramics type 180R or capacitor of same quality.
- 3. The striplines are on a double copper-clad printed-circuit board: Rogers 5880 ( $\varepsilon_r$  = 2.2); thickness 0.79 mm.

## UHF power LDMOS transistor

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Dimensions in mm.

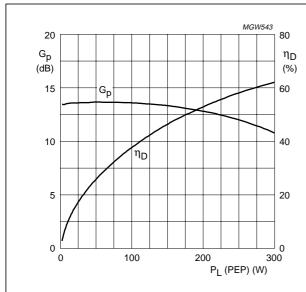
The components are situated on one side of the Rogers 5880 printed-circuit board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.7 Printed-circuit board and component layout for class-AB 600 MHz test circuit.

## **UHF** power LDMOS transistor

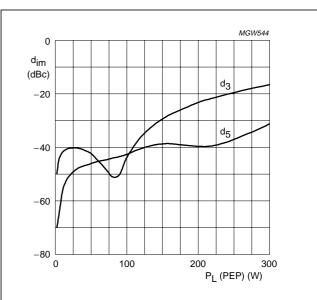
**BLF647** 

#### Application at 800 MHz



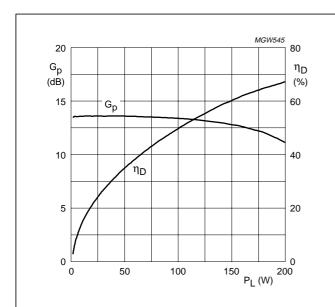
 $T_h$  = 25 °C;  $V_{DS}$  = 32 V;  $I_{DQ}$  = 1 A. 2-tone:  $f_1$  = 800 MHz (–6 dB);  $f_2$  = 800.1 MHz (–6 dB) measured in 800 MHz test circuit.

Fig.8 Power gain and drain efficiency as functions of peak envelope load power; typical values



 $T_h$  = 25 °C;  $V_{DS}$  = 32 V;  $I_{DQ}$  = 1 A. 2-tone:  $f_1$  = 800 MHz (–6 dB);  $f_2$  = 800.1 MHz (–6 dB) measured in 800 MHz test circuit.

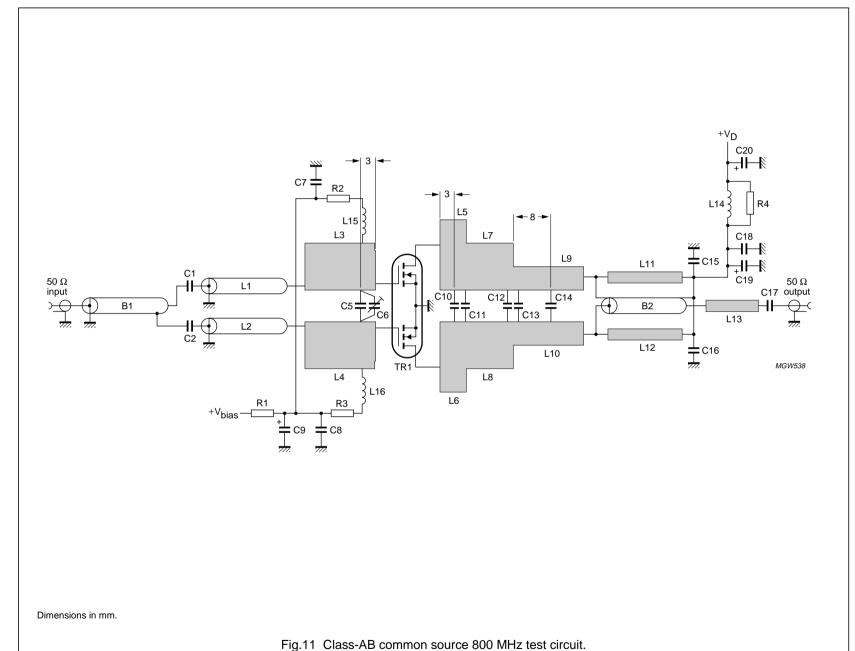
Fig.9 Intermodulation distortion as a function of peak envelope output power; typical values.



 $\rm T_h = 25~^{\circ}C;~V_{DS} = 32~V;~I_{DQ} = 1~A;~CW,~class-AB;~f = 800~MHz;~measured~in~800~MHz~test~circuit.$ 

Fig.10 Power gain and drain efficiency as functions of load power; typical values.

Product specification



## UHF power LDMOS transistor

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#### List of components class-AB 800 MHz test circuit (see Figs 11 and 12)

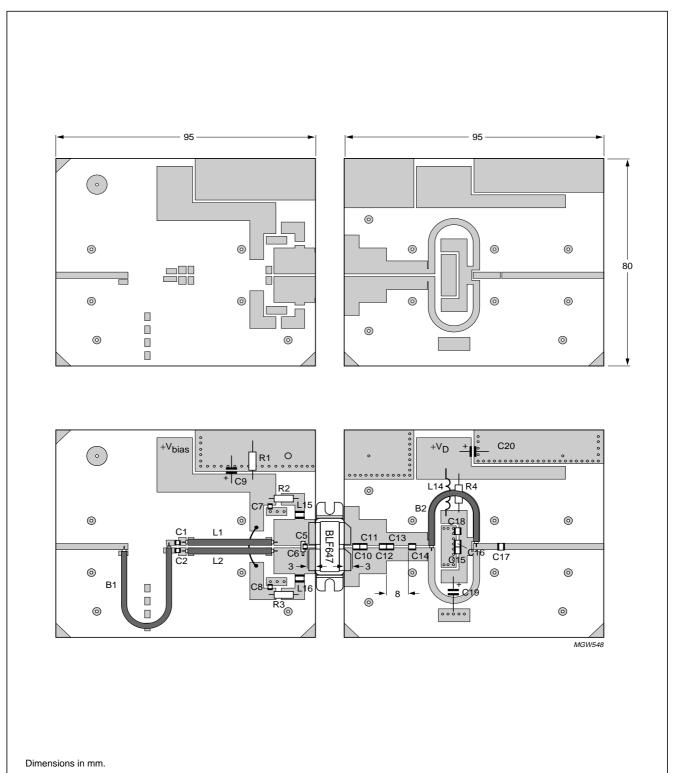
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE No.
C1, C2	multilayer ceramic chip capacitor; note 1	30 pF		
C5	multilayer ceramic chip capacitor; note 1	10 pF		
C6	tekelec trimmer	0.6 to 7.5 pF		
C7, C8	multilayer ceramic chip capacitor; note 1	100 pF		
C9	electrolytic capacitor	10 μF		
C10, C11	multilayer ceramic chip capacitor; note 2	8.2 pF		
C12, C13	multilayer ceramic chip capacitor; note 2	10 pF		
C14	multilayer ceramic chip capacitor; note 2	4.7 pF		
C15, C16	multilayer ceramic chip capacitor; note 2	100 pF		
C17	multilayer ceramic chip capacitor; note 2	20 pF		
C18	SMD capacitor	1 μF		2222 595 16754
C19	electrolytic capacitor	470 μF		
C20	electrolytic capacitor	100 μF		
L1, L2	semi rigid coax UT70-25	$Z = 25 \Omega \pm 1.5 \Omega$	30.6 mm	
L3, L4	stripline; note 3		15 × 10 mm	
L5, L6	stripline; note 3		5.5 × 15 mm	
L7, L8	stripline; note 3		10 × 10 mm	
L9, L10	stripline; note 3		15 × 5 mm	
L11, L12	stripline; note 3		48.5 × 2.4 mm	
L13	stripline; note 3		10 × 2.4 mm	
L14	ferrite			
L15, L16	Coilcraft SMD coil 1008CS-102XKBC	1 μΗ		
B1	semi rigid coax (lambda/2)	$Z = 50 \Omega \pm 1.5 \Omega$	lambda/2	
B2	semi rigid coax balun UT70-25	$Z = 25 \Omega \pm 1.5 \Omega$	48.5 mm	
R1	resistor	1 kΩ		
R2, R3	resistor	100 Ω		
R4	resistor	3,3 Ω		

#### Notes

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. American Technical Ceramics type 180R or capacitor of same quality.
- 3. The striplines are on a double copper-clad printed-circuit board: Rogers 5880 ( $\varepsilon_r$  = 2.2); thickness 0.79 mm.

## UHF power LDMOS transistor

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The components are situated on one side of the Rogers 5880 printed-circuit board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.12 Printed-circuit board and component layout for class-AB 800 MHz test circuit.

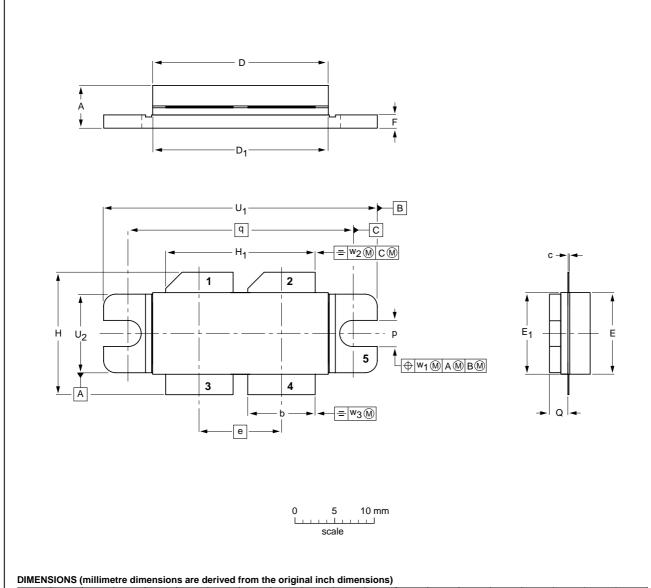
## UHF power LDMOS transistor

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#### **PACKAGE OUTLINE**

#### Flanged balanced LDMOST ceramic package; 2 mounting holes; 4 leads

SOT540A



UNIT	Α	b	С	D	D <sub>1</sub>	е	E	E <sub>1</sub>	F	н	Н <sub>1</sub>	р	Q	q	U <sub>1</sub>	U <sub>2</sub>	w <sub>1</sub>	w <sub>2</sub>	w <sub>3</sub>
mm	5.77 5.00	8.51 8.26	0.15 0.10	22.05 21.64	22.05 21.64	10.21	10.26 10.06	10.31 10.01	1.78 1.52	15.75 14.73	18.72 18.47	3.38 3.12	2.72 2.46	27.94	34.16 33.91	9.91 9.65	0.25	0.51	0.25
inches	0.227 0.197	0.335 0.325	0.006 0.004	0.868 0.852	0.868 0.852	0.402	0.404 0.396	0.406 0.394	0.070 0.060	0.620 0.580	0.737 0.727	0.133 0.123	0.107 0.097	1.100	1.345 1.335	0.390 0.380	0.010	0.020	0.010

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT540A						<del>-99-08-27</del> 99-12-28

## **UHF** power LDMOS transistor

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DATA SHEET STATUS(1)	PRODUCT STATUS <sup>(2)</sup>	DEFINITIONS
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